

Numerical Optimization of a Microtransformer

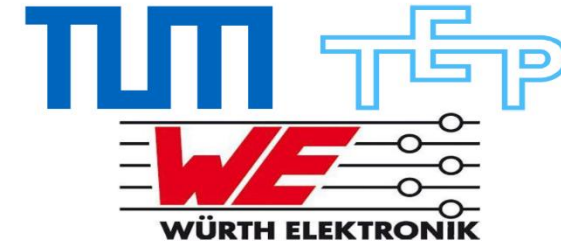
more
than you
expect



WOST
June 22, 2018

Presenter:
**Waschriporn
Ampunant**

Agenda



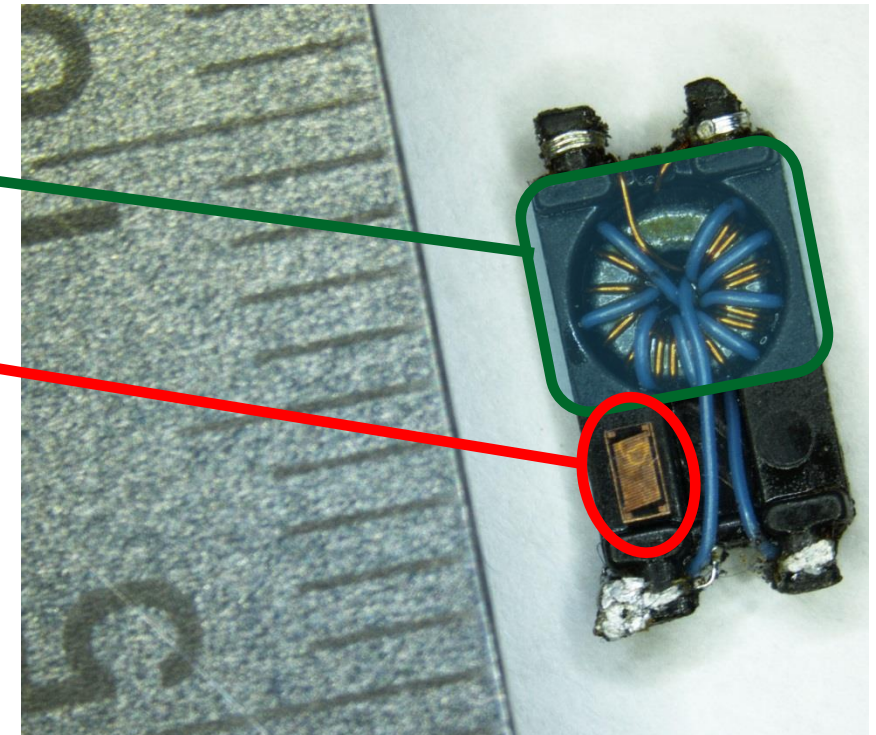
- *Motivation*
- Target
- Electromagnetic Simulation
- Workflow
- Sensitivity Analysis
- Optimization
- Results and Outlook

Motivation

- **Target:**
 - Reduction of device size with simultaneous extension of the range of functions
- **Realization:**
 - High switch frequency (over 20 MHz) → Decrease of inductance value → Reduction of device size
- **Problem:**
 - Difficult fabrication
 - Expensive prototype manufacturing
- **So far:**
 - Parameter sweep based on experience
- **Approach:**
 - Model optimization using ANSYS optiSlang

Wire-wounded Trafo

MicroTrafo



Agenda

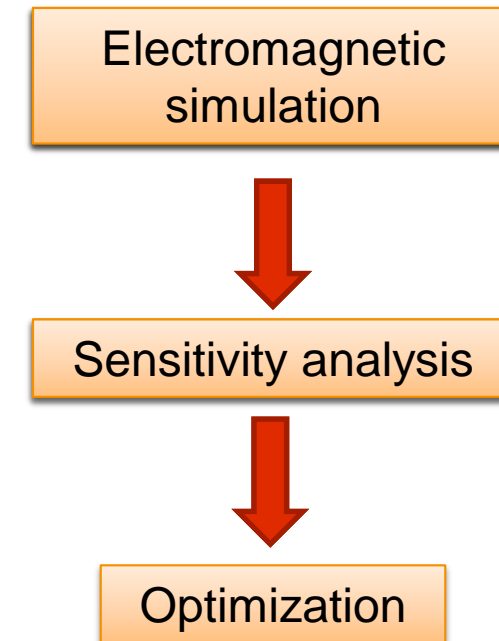
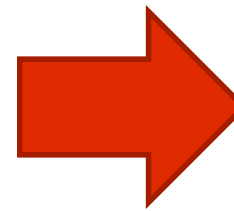
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Target

- Optimization of a microtransformer by using ANSYS Maxwell and ANSYS optiSlang:

Market requirements:

- Minimization of the ohmic resistance
- Inductance between 20 - 50nH
- Coupling factor ≥ 0.8
- Capacitance $\leq 5\text{pF}$

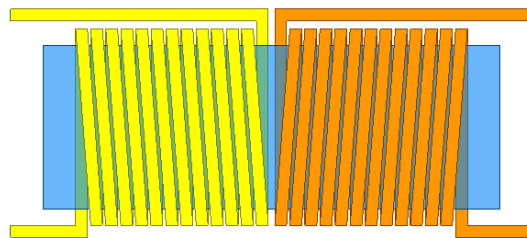
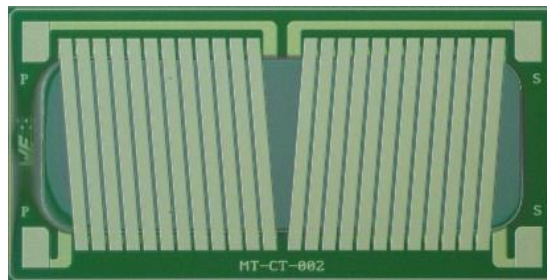


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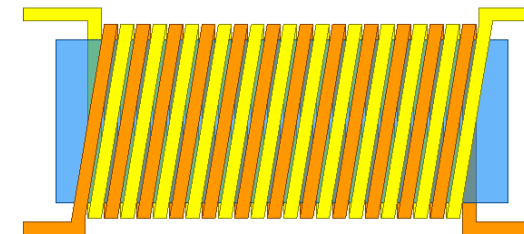
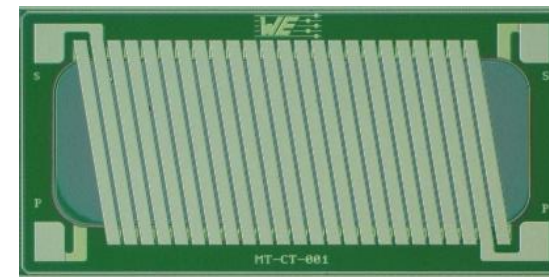
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Electromagnetic Simulation

- Comparison of the primary-secondary model and the interleave model



Primary-secondary model

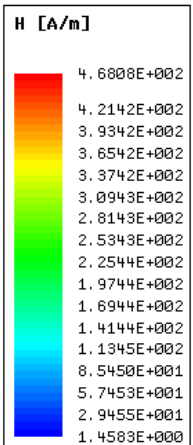
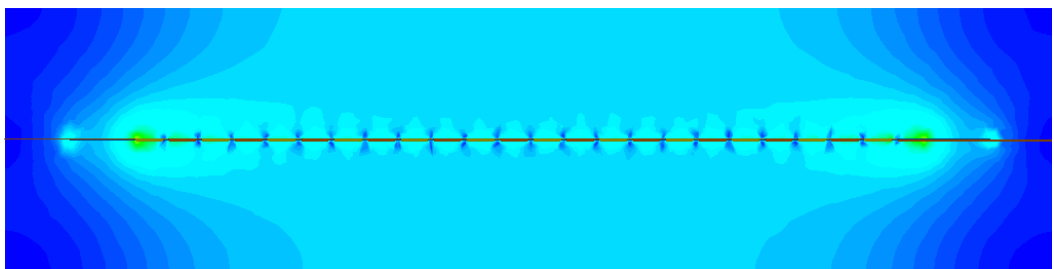
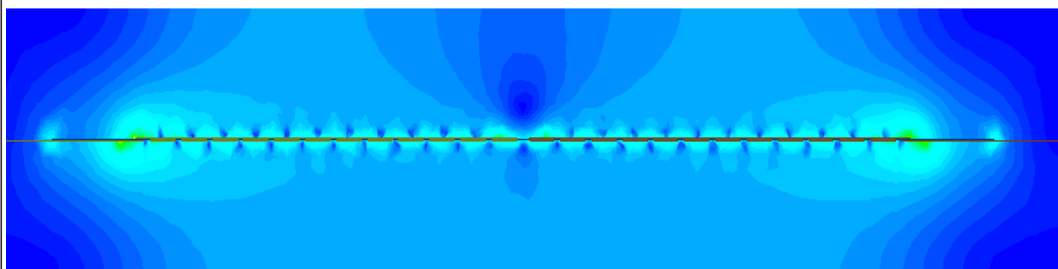
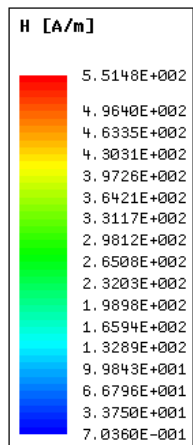
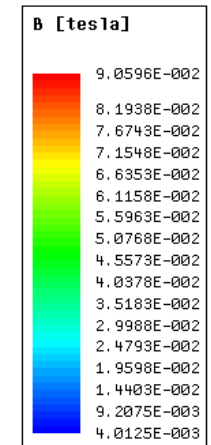
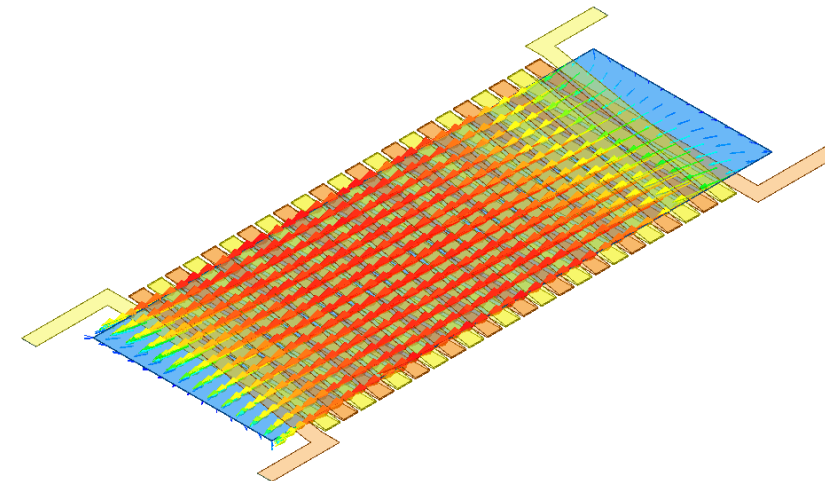
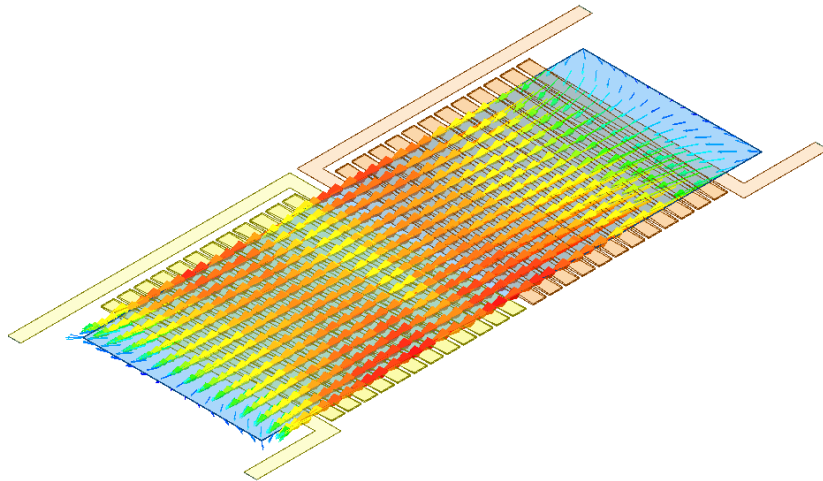
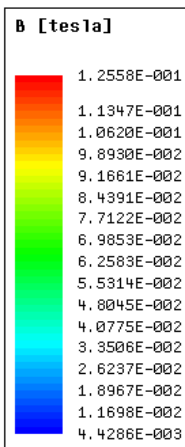


Interleave model

Dimension: 1400 μm \times 600 μm \times 3.3 μm

Electromagnetic Simulation

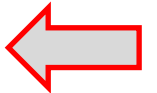
- Comparison of the field results from primary-secondary model and the interleave model



Electromagnetic Simulation

- Comparison of the simulation results from primary-secondary model and the interleave model

Parameter	Primary-secondary model	Interleave model
Resistance	19.23 Ω	16.08 Ω
Inductance	41.54 nH	23.11 nH
Coupling factor	0.07	0.74
Capacitance	20.35 pF	21.93 pF



Target:

- Minimization of the ohmic resistance
- Inductance 20 – 50 nH
- Coupling factor ≥ 0.8
- Capacitance ≤ 5 pF



Comparison of the coupling factor:
Interleave model will be used for further analysis

Electromagnetic Simulation

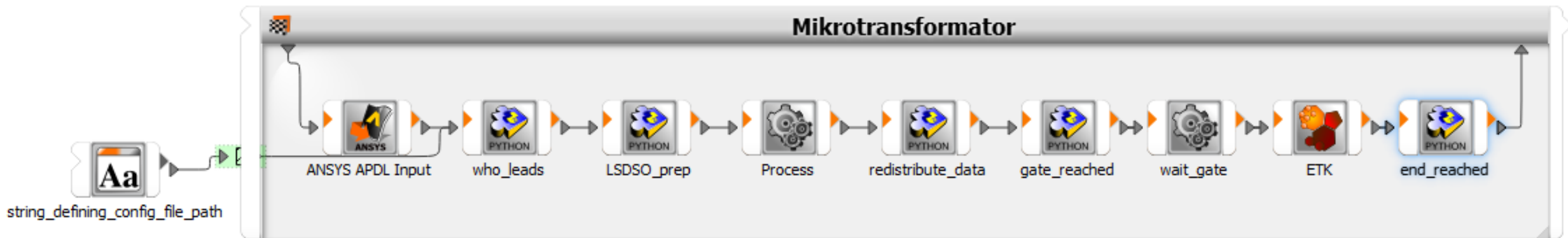
	Number	Parameter	Description
Input parameter	1	coreLength	Length of the core
	2	coreWidth	Width of the core
	3	coreHeight	Height of the core
	4	coilHeight	Height of the coil
	5	distanceEnd	Length of the core, which sticks out of the coil
	6	gapCoilX	Gap between two turns in x-direction
	7	gapCoilZ	Gap between two cores
	8	gapBetweenCC	Gap between coil and core in z-direction
	9	via	Gap between coil and core in y-direction
	10	turns	Number of turns
Response	1	RDC	Ohmic resistance – objective
	2	L	Inductance – constraint
	3	CplCoef	Coupling factor – constraint
	4	C	Capacitance – constraint

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Workflow

- Implementation of the coupling between ANSYS Maxwell und ANSYS optiSlang with the LS-DSO (Large Scale – Distributed Solve Option) workflow



- Advantages:
 - Parallelization of the computation
 - All designs of one iteration bounded in one LS-DSO job
 - Simulation works in the background

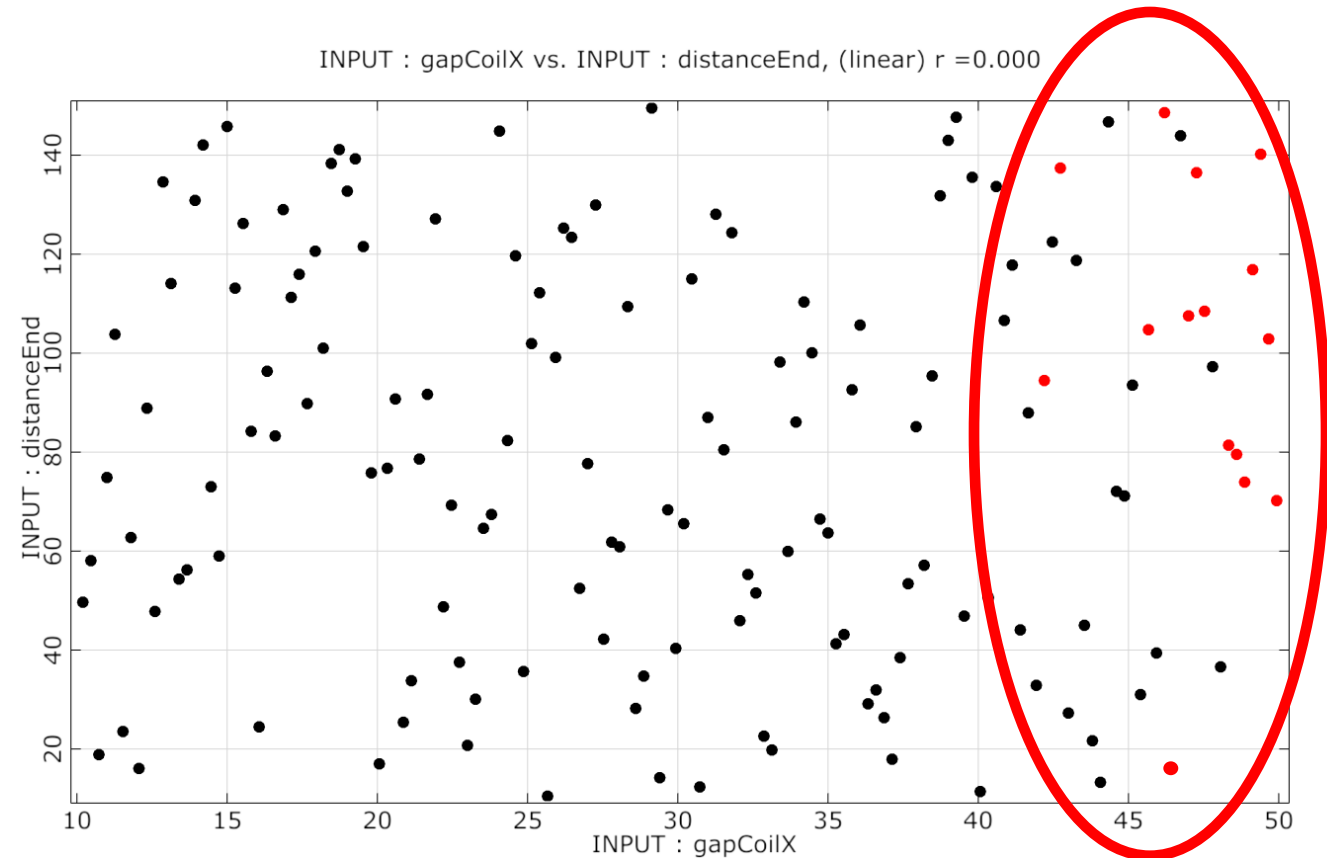
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Sensitivity Analysis

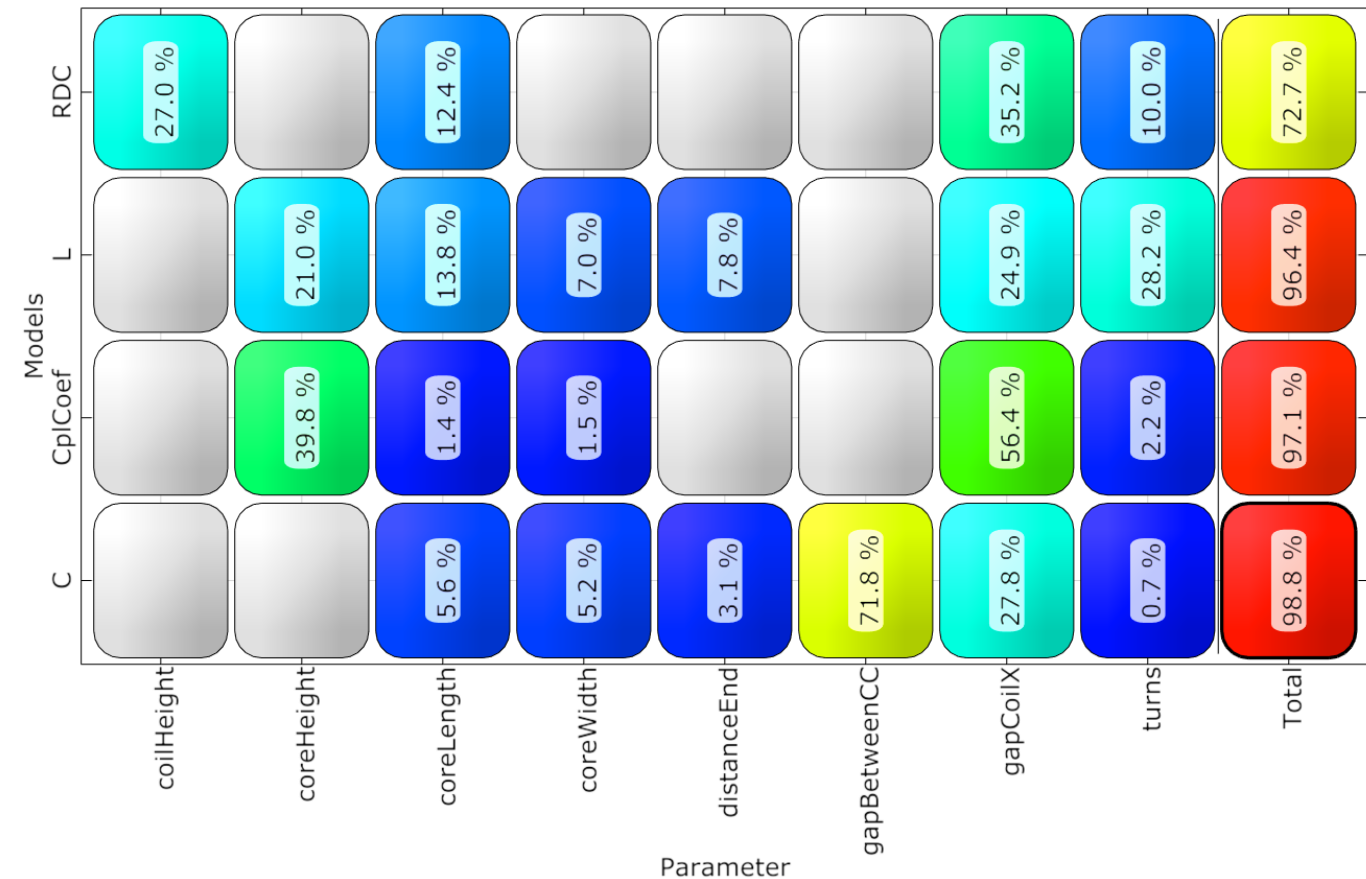
Target of the sensitivity analysis:

- Understand system behavior
 - 15 failed designs in the range of small coil cross sections
 - No automatic identification of the boundary condition
- Determine dependence and ranking between input parameters and responses
- Receive a “Metamodel of Optimal Prognosis” (MOP) with a reduced number of the input parameters



Sensitivity Analysis

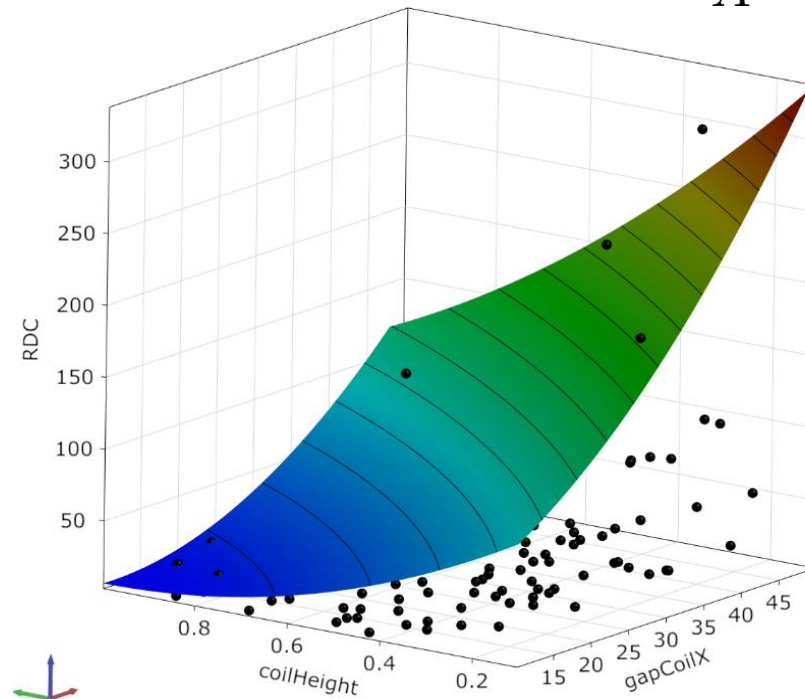
- “Coefficient of Prognosis” (CoP) matrix
 - CoP as a measure of quality for the MOP
 - Illustrates the dependence of the input parameters and the responses with ranking
 - *2 input parameters are irrelevant for all responses*
 - *Objective depends on 4 input parameters instead of 10*
 - Influence valid only within the chosen input parameter range



Sensitivity Analysis

- Response Surface Plot: relation between one response and the two input parameters

ohmic resistance: $R = \rho \frac{l}{A}$

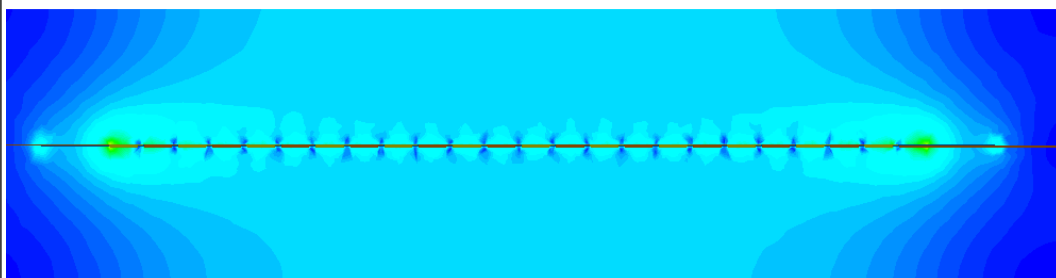
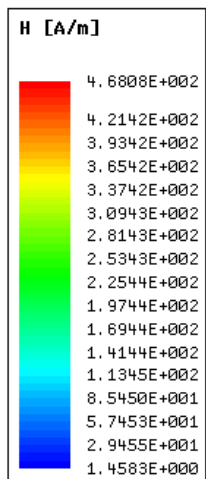
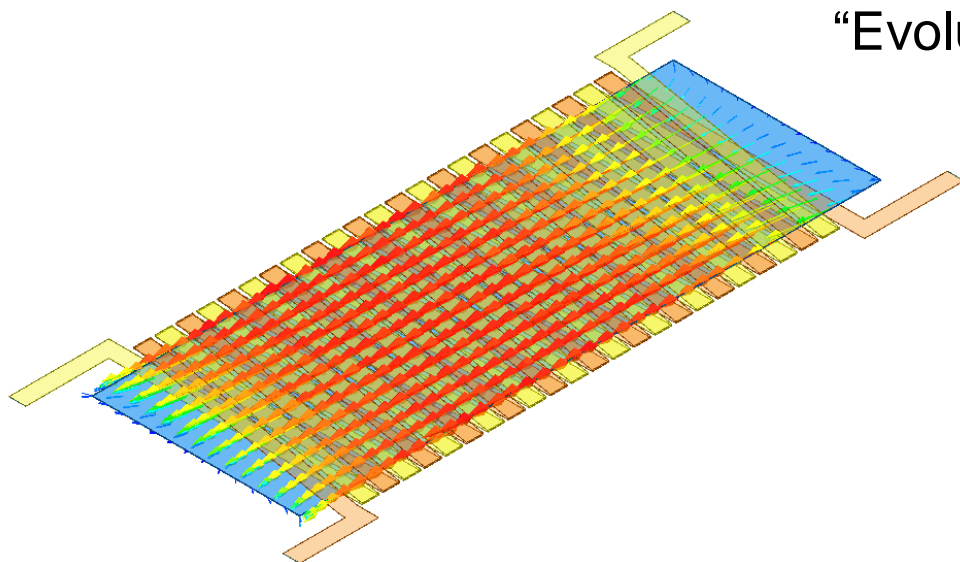
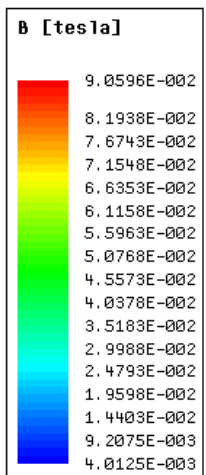


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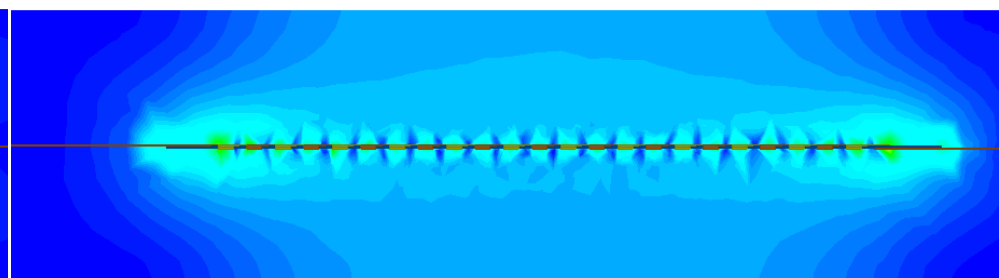
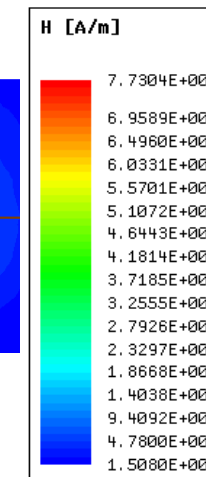
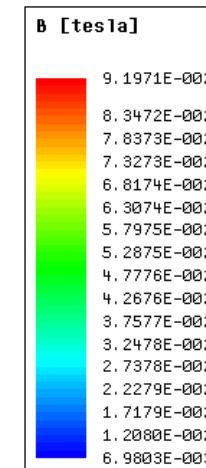
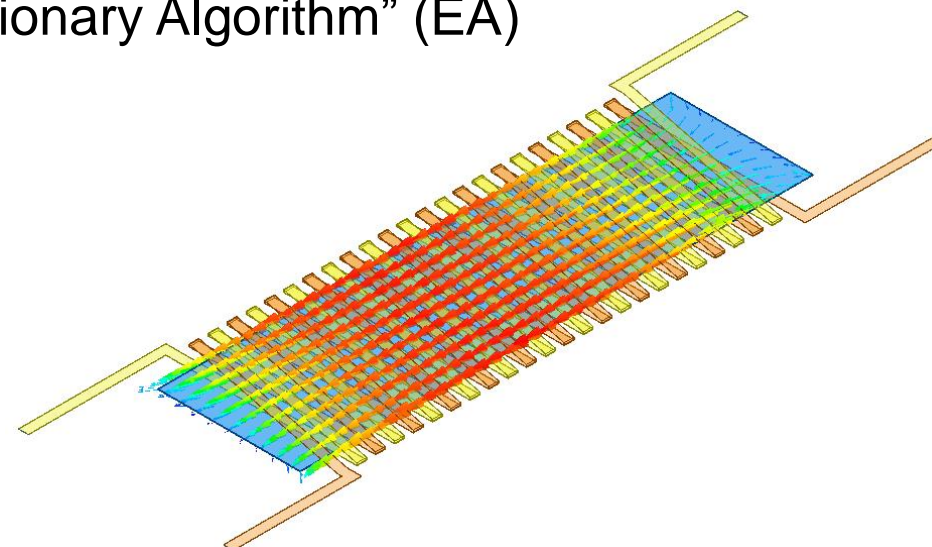
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Optimization

- Insufficient CoP of 73% for the objective RDC resulted in the use of “Evolutionary Algorithm” (EA)



1400 μm × 600 μm × 3.3 μm



1114 μm × 417 μm × 5.9 μm

Optimization

- Comparison of the results of the initial model and the optimized model

	Initial model	Optimized model
Dimension	1400 μm \times 600 μm \times 3.3 μm	1114 μm \times 417 μm \times 5.9 μm
Ohmic resistance	16 Ω	9 Ω
Inductance	23.11 nH	28.46 nH
Coupling factor	0.74	0.8
Capacitance	21.93 pF	4 pF

- Reduction of the ohmic resistance 
- Inductance of 20 – 50 nH 
- Coupling factor ≥ 0.8 
- Capacitance $\leq 5\text{pF}$ 

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Results and Outlook

Results:

- Sensitivity analysis: Reduction of the number of the input parameters from 10 to 8 for the optimization, in particular, from 10 to 4 input parameters for the objective
- Achieve the optimization target by downsizing the area of the model and increasing the thickness of the model
 - Ohmic resistance ✓
 - Inductance ✓
 - Coupling factor ✓
 - Capacitance ✓



Outlook:

- Improvement of the simulation model
- Verification of the simulation results with the measurement results

Thank you for your attention!

Questions?